

PBHV8140Z
500 V, 1 A NPN high-voltage low $\mathrm{V}_{\text {CEsat }}$ (BISS) transistor
Rev. 01 - 11 December 2009 Product data sheet

## 1. Product profile

### 1.1 General description

NPN high-voltage low $\mathrm{V}_{\text {CEsat }}$ Breakthrough In Small Signal (BISS) transistor in a medium power SOT223 (SC-73) Surface-Mounted Device (SMD) plastic package.

PNP complement: PBHV9540Z.

### 1.2 Features

- High voltage
- Low collector-emitter saturation voltage $\mathrm{V}_{\text {CEsat }}$
- High collector current capability $\mathrm{I}_{\mathrm{C}}$ and $\mathrm{I}_{\mathrm{CM}}$
- High collector current gain ( $\mathrm{h}_{\mathrm{FE}}$ ) at high $\mathrm{I}_{\mathrm{C}}$
- AEC-Q101 qualified
- Medium power SMD plastic package


### 1.3 Applications

- LED driver for LED chain module
- LCD backlighting
- Automotive motor management
- Switch Mode Power Supply (SMPS)


### 1.4 Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| $\mathrm{V}_{\text {CESM }}$ | collector-emitter peak <br> voltage | $\mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}$ | - | - | 500 | V |
|  | collector-emitter voltage | open base | - | - | 400 | V |
| $\mathrm{~V}_{\mathrm{CEO}}$ | collector current |  | - | - | 1 | A |
| $\mathrm{I}_{\mathrm{C}}$ | DC current gain | $\mathrm{V}_{\mathrm{CE}}=10 \mathrm{~V} ;$ <br> $\mathrm{I}_{\mathrm{FE}}$ | $\underline{[1]}$ | 100 | 155 | - |

[1] Pulse test: $\mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02$.


## 2. Pinning information

Table 2. Pinning

| Pin | Description | Simplified outline | Graphic symbol |
| :---: | :---: | :---: | :---: |
| 1 | base |  |  |
| 2 | collector |  | 2, 4 |
| 3 | emitter |  |  |
| 4 | collector |  | $3$ |
|  |  |  | sym016 |

## 3. Ordering information

Table 3. Ordering information

| Type number | Package |  |  |  |
| :--- | :--- | :--- | :--- | :--- |
|  |  |  |  |  |
|  | Name | Description | Version |  |
| PBHV8140Z | SC-73 | plastic surface-mounted package with increased <br> heatsink; 4 leads | SOT223 |  |

## 4. Marking

Table 4. Marking codes

| Type number | Marking code |
| :--- | :--- |
| PBHV8140Z | V8140Z |

## 5. Limiting values

Table 5. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $V_{\text {Cbo }}$ | collector-base voltage | open emitter | - | 500 | V |
| $V_{\text {CEO }}$ | collector-emitter voltage | open base | - | 400 | V |
| $\mathrm{V}_{\text {CESM }}$ | collector-emitter peak voltage | $\mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}$ | - | 500 | V |
| $V_{\text {Ebo }}$ | emitter-base voltage | open collector | - | 6 | V |
| $I_{C}$ | collector current |  | - | 1 | A |
| $I_{\text {CM }}$ | peak collector current | single pulse; $\mathrm{t}_{\mathrm{p}} \leq 1 \mathrm{~ms}$ | - | 2 | A |
| $I_{B M}$ | peak base current | single pulse; $\mathrm{t}_{\mathrm{p}} \leq 1 \mathrm{~ms}$ | - | 400 | mA |
| $\mathrm{P}_{\text {tot }}$ | total power dissipation | $\mathrm{T}_{\text {amb }} \leq 25^{\circ} \mathrm{C}$ | [1] | 0.73 | W |
|  |  |  | [2] | 1.45 | W |
| $\mathrm{T}_{\mathrm{j}}$ | junction temperature |  | - | 150 | ${ }^{\circ} \mathrm{C}$ |
| Tamb | ambient temperature |  | -55 | +150 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | storage temperature |  | -65 | +150 | ${ }^{\circ} \mathrm{C}$ |

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for collector $6 \mathrm{~cm}^{2}$.

(1) FR4 PCB, mounting pad for collector $6 \mathrm{~cm}^{2}$
(2) FR4 PCB, standard footprint

Fig 1. Power derating curves

## 6. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions |  | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{R}_{\mathrm{th}(-\mathrm{a}}$ | thermal resistance from junction to ambient | in free air | [1] | - | - | 170 | K/W |
|  |  |  | [2] | - | - | 85 | K/W |
| $\mathrm{R}_{\text {th( }}$-sp) | thermal resistance from junction to solder point |  |  | - | - | 15 | K/W |

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated and mounting pad for collector $6 \mathrm{~cm}^{2}$.


FR4 PCB, standard footprint
Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values


FR4 PCB, mounting pad for collector $6 \mathrm{~cm}^{2}$
Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

## 7. Characteristics

Table 7. Characteristics
$T_{\text {amb }}=25^{\circ} \mathrm{C}$ unless otherwise specified.

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{I}_{\text {cbo }}$ | collector-base cut-off current | $\mathrm{V}_{\mathrm{CB}}=320 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=0 \mathrm{~A}$ | - | - | 100 | nA |
|  |  | $\begin{aligned} & \mathrm{V}_{\mathrm{CB}}=320 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=0 \mathrm{~A} ; \\ & \mathrm{T}_{\mathrm{j}}=150^{\circ} \mathrm{C} \end{aligned}$ | - | - | 10 | $\mu \mathrm{A}$ |
| $I_{\text {CES }}$ | collector-emitter cut-off current | $\mathrm{V}_{C E}=320 \mathrm{~V} ; \mathrm{V}_{\mathrm{BE}}=0 \mathrm{~V}$ | - | - | 100 | nA |
| $\mathrm{I}_{\text {ebo }}$ | emitter-base cut-off current | $\mathrm{V}_{\mathrm{EB}}=4 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=0 \mathrm{~A}$ | - | - | 100 | nA |
| $\mathrm{h}_{\text {FE }}$ | DC current gain | $\mathrm{V}_{\text {CE }}=10 \mathrm{~V}$ |  |  |  |  |
|  |  | $\mathrm{I}_{\mathrm{C}}=50 \mathrm{~mA}$ | 100 | 155 | - |  |
|  |  | $\mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA}$ | [1] 80 | 150 | - |  |
|  |  | $\mathrm{I}_{\mathrm{C}}=500 \mathrm{~mA}$ | [1] 35 | 65 | - |  |
|  |  | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A}$ | [1] 10 | 20 | - |  |
| $\mathrm{V}_{\text {CEsat }}$ | collector-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA} ; \mathrm{I}_{\mathrm{B}}=10 \mathrm{~mA}$ | [1] - | 45 | 80 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=100 \mathrm{~mA} ; \mathrm{I}_{\mathrm{B}}=20 \mathrm{~mA}$ | [1] - | 30 | 50 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=500 \mathrm{~mA} ; \mathrm{I}_{\mathrm{B}}=100 \mathrm{~mA}$ | [1] - | 85 | 140 | mV |
|  |  | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=200 \mathrm{~mA}$ | [1] - | 150 | 250 | mV |
| $\mathrm{R}_{\text {CEsat }}$ | collector-emitter saturation resistance | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=200 \mathrm{~mA}$ | [1] - | 150 | 250 | $\mathrm{m} \Omega$ |
| $V_{\text {BEsat }}$ | base-emitter saturation voltage | $\mathrm{I}_{\mathrm{C}}=1 \mathrm{~A} ; \mathrm{I}_{\mathrm{B}}=200 \mathrm{~mA}$ | [1] - | 0.95 | 1.1 | V |
| $\mathrm{t}_{\mathrm{d}}$ | delay time | $\begin{aligned} & \mathrm{V}_{\mathrm{CC}}=6 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=0.5 \mathrm{~A} ; \\ & \mathrm{I}_{\text {Bon }}=0.1 \mathrm{~A} ; \mathrm{I}_{\text {Boff }}=-0.1 \mathrm{~A} \end{aligned}$ | - | 25 | - | ns |
| $\mathrm{t}_{\mathrm{r}}$ | rise time |  | - | 2820 | - | ns |
| $\mathrm{t}_{\mathrm{on}}$ | turn-on time |  | - | 2845 | - | ns |
| $\mathrm{t}_{\mathrm{s}}$ | storage time |  | - | 2585 | - | ns |
| $\mathrm{t}_{\mathrm{f}}$ | fall time |  | - | 1215 | - | ns |
| $\mathrm{t}_{\text {fff }}$ | turn-off time |  | - | 3800 | - | ns |
| $\mathrm{f}_{\mathrm{T}}$ | transition frequency | $\begin{aligned} & V_{C E}=10 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=10 \mathrm{~mA} ; \\ & \mathrm{f}=100 \mathrm{MHz} \end{aligned}$ | - | 25 | - | MHz |
| $\mathrm{C}_{\mathrm{c}}$ | collector capacitance | $\begin{aligned} & \mathrm{V}_{\mathrm{CB}}=20 \mathrm{~V} ; \mathrm{I}_{\mathrm{E}}=\mathrm{i}_{\mathrm{e}}=0 \mathrm{~A} ; \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ | - | 12 | - | pF |
| $\mathrm{C}_{\text {e }}$ | emitter capacitance | $\begin{aligned} & V_{E B}=0.5 \mathrm{~V} ; \mathrm{I}_{\mathrm{C}}=\mathrm{i}_{\mathrm{C}}=0 \mathrm{~A} ; \\ & \mathrm{f}=1 \mathrm{MHz} \end{aligned}$ | - | 600 | - | pF |

[1] Pulse test: $\mathrm{t}_{\mathrm{p}} \leq 300 \mu \mathrm{~s} ; \delta \leq 0.02$.


$$
V_{C E}=10 \mathrm{~V}
$$

(1) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(3) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$

Fig 4. DC current gain as a function of collector current; typical values


$$
V_{C E}=10 \mathrm{~V}
$$

(1) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(3) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$

Fig 6. Base-emitter voltage as a function of collector current; typical values

$\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$

Fig 5. Collector current as a function of collector-emitter voltage; typical values


$$
\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=5
$$

(1) $\mathrm{T}_{\text {amb }}=-55^{\circ} \mathrm{C}$
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(3) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$

Fig 7. Base-emitter saturation voltage as a function of collector current; typical values


Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values

$\mathrm{IC}_{\mathrm{C}} \mathrm{I}_{\mathrm{B}}=5$
(1) $\mathrm{T}_{\mathrm{amb}}=100^{\circ} \mathrm{C}$
(2) $\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(3) $\mathrm{T}_{\mathrm{amb}}=-55^{\circ} \mathrm{C}$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values

$\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(1) $\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=20$
(2) $\mathrm{I}_{\mathrm{C}} \mathrm{I}_{\mathrm{B}}=10$
(3) $I_{C} / I_{B}=5$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values

$\mathrm{T}_{\mathrm{amb}}=25^{\circ} \mathrm{C}$
(1) $\mathrm{I}_{\mathrm{C}} \mathrm{I}_{\mathrm{B}}=20$
(2) $\mathrm{I}_{\mathrm{C}} \mathrm{I}_{\mathrm{B}}=10$
(3) $\mathrm{I}_{\mathrm{C}} / \mathrm{I}_{\mathrm{B}}=5$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values

## 8. Test information



Fig 12. Test circuit for switching times

### 8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q101 - Stress test qualification for discrete semiconductors, and is suitable for use in automotive applications.

## 9. Package outline



Fig 13. Package outline SOT223 (SC-73)

## 10. Packing information

Table 8. Packing methods
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

| Type number | Package | Description | Packing quantity |  |
| :--- | :--- | :--- | :--- | :--- | :--- |
|  |  |  | $\mathbf{1 0 0 0}$ | 4000 |
| PBHV8140Z | SOT223 | 8 mm pitch, 12 mm tape and reel | -115 | -135 |

[1] For further information and the availability of packing methods, see Section 14.

## 11. Soldering



Fig 14. Reflow soldering footprint SOT223 (SC-73)


Zllat solder lands
----- solder resist

Dimensions in mm
preferred transport
direction during solderin
sot223_fw
Fig 15. Wave soldering footprint SOT223 (SC-73)

## 12. Revision history

Table 9. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
| :--- | :--- | :--- | :--- | :--- | :--- |
| PBHV8140Z_1 | 20091211 | Product data sheet | - | - |

## 13. Legal information

### 13.1 Data sheet status

| Document status $\underline{[1][2]}$ | Product status $\underline{[3]}$ | Definition |
| :--- | :--- | :--- |
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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## 14. Contact information

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